

# Search Notes



Application/Control No.

10/519,854

Examiner

Hae M. Hyeon

Applicant(s)/Patent under Reexamination

CLAUS ET AL.

Art Unit

2839

## SEARCHED

Class	Subclass	Date	Examiner
Search	Updated	2/06	hnh

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
439	194	2/06	hnh
439	427	↓	↓

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Interference Search Done	2/06	hnh